Data sheet acquired from Harris Semiconductor HS070B - Revised June 2003

CMOS Dual 4-Bit Latch

High-Voltage Types (20-Volt Rating)

CD4508B dual 4-bit latch contains two identical 4-bit latches with separate STROBE, RESET, and OUTPUT DISABLE controls. With the STROBE line in the high state, the data on the "D" inputs appear at the corresponding " Ω " outputs provided the DISABLE line is in the low state. Changing the STROBE line to the low state locks the data into the latch. A high on the reset line forces the outputs to a low level regardless of the state of the STROBE input. The outputs are forced to the high-impedance state for bus line applications by a high level on the DISABLE input.

The CD4508B types are supplied in 24-lead hermetic dual-in-line ceramic packages (F3A suffix), 24-lead dual-in-line plastic packages (E suffix), 24-lead small-outline packages (M, M96, and NSR suffixes), and 24-lead thin shrink small-outline packages (PW and PWR suffixes).

The CD4508B is similar to industry type MC14508.

MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE RANGE, (VDD)

POWER DISSIPATION PER PACKAGE (PD):

For T_A = -55°C to +100°C

DEVICE DISSIPATION PER OUTPUT TRANSISTOR

LEAD TEMPERATURE (DURING SOLDERING):

Features:

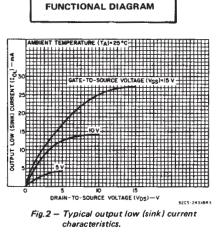
- Two independent 4-bit latches
- Individual master reset for each 4-bit latch
- 3-state outputs with high-impedance state for bus line applications
- Medium-speed operation: tpHL = tpLH = 70 ns (typ.) at V_{DD} = 10 V and C_{L} = 50 pF
- 100% tested for guiescent current at 20 V
- 5-V, 10-V, and 15-V parametric ratings
- Standardized, symmetrical output characteristics
- Maximum input current of 1 µA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (full package-temperature range).=
 - 1 V at V_{DD} = 5 V
 - 2 V at V_{DD} = 10 V
 - 2.5 V at VDD = 15 V
- Meets all requirements of JEDEC Tentative Standard No. 13B,"Standard Specifications for Description of 'B' Series **CMOS Devices**"

Applications:

- Buffer storage
- Holding registers
- Data storage and multiplexing

	DIA 4- BIT 3-STATE QIA D2A 4-BIT 3-STATE Q2A

OIR



92C5 - 27494R

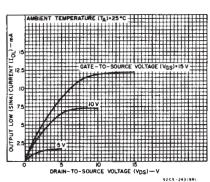
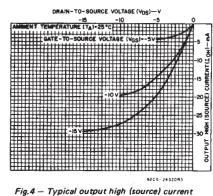


Fig.3 - Minimum output low (sink) current characteristics.



characteristics.

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RECOMMENDED OPERATING CONDITIONS at T_A = 25°C, Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

For T_A = +100°C to +125°C..... Derate Linearity at 12mW/°C to 200mW

At distance 1/16 ± 1/32 inch (1.59 ± 0.79mm) from case for 10s max +265°C

STORAGE TEMPERATURE RANGE (Tstg)-65°C to +150°C

	VDD	LIN	ITS	
CHARACTERISTIC	(V)	Min.	Max.	UNITS
Supply-Voltage Range (For T _A = Full Package- Temperature Range)		3	18	v
	5	200	-	
Reset Pulse Width, tw(R)	10	140	-	
	15	100	-	
	5	140	_	1
Strobe Pulse Width, tW(st)	10	80	-	
	15	70	-	ns
	5	50	_	
Setup Time, t _{SU}	10	30	- 1	
	15	20	-	
	5	0] .
Hold Time, t _H	10	0		
	15	0		

CD4508B Types

OUTPU

DIS

D28

D38

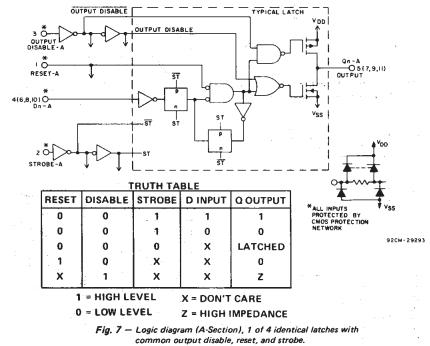
STROBE

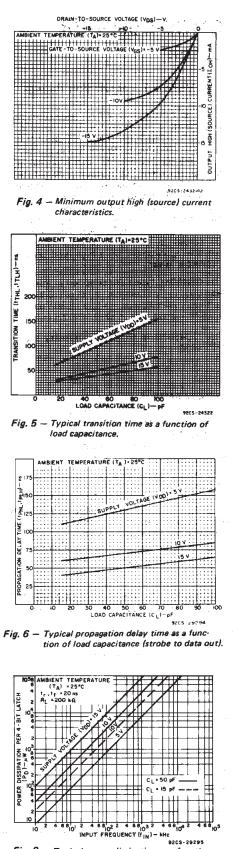
RESET

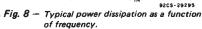
3

STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	CONE	IS	LIMIT	LIMITS AT INDICATED TEMPERATURES (°C)							
ISTIC	Vo	VIN	VDD						+25		UNITS
	(V)	(V)	(V)	-55	-40	+85	+125	Min.	Typ.	Max.	
Quiescent Device		0,5	5	5	5	150	150	-	0.04	5	
Current,		0,10	10	10	10	300	300		0.04	10	
IDD Max.	-	0,15	15	20	20	600	600		0.04	20	μA
	. – .	0,20	20	100	100	3000	3000	- 1,	0.08	100	1
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1		
(Sink) Current	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	-	1
IOL Min.	1.5	0,15	15	4.2	4	2.8	2.4	34	6.8	-	
Output High	4,6	0,5	5	-0.64	- 0 .61	-0.42	-0.36	-0.51	-1	-	mA
(Source) Current, IOH Min.	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2		
	9.5	0,10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6		
	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	, - 1	(1,1,1)
Output Voltage:	-	0,5	5		0	.05			0	0,05	
Low-Level,	-	0,10	10		0	.05		-	0	0.05	
VOL Max.		0,15	15		0	.05		-	0	0.05	
Output Voltage:	-	0,5	5		4	.95		4.95	5	-	ľ
High-Level,	_	0,10	10	9.95 9.95 10 -						-	1
VOH Min.	-	0,15	15		14	1.95		14.95	15		· · · ·
Input Low	0.5, 4.5	`	5		1	.5		_	-	1.5	1997 - A. A.
Voltage,	1, 9	· -	10			3			• <u>000</u> 1	· 3 ·	6 < 40
VIL Max.	1.5,13.5		15			4		_	-	4	v
Input High	0.5, 4.5	-	5		3	3.5		3.5	-	_	v
Voltage,	1, 9		10			7		7	_	_	
VIH Min.	1.5,13.5	$\sim \simeq \gamma$	15		1	1		11	—	-	
Input Current IIN Max.	-	0,18	18	±0.1	±0.1	±1	±1	-	±10 ⁻⁵	±0.1	μA
3-State Output Leakage Current IOUT Max.	0,18	0,18	18	±0.4	±0.4	±12	±12		±10-4	±0.4	μA

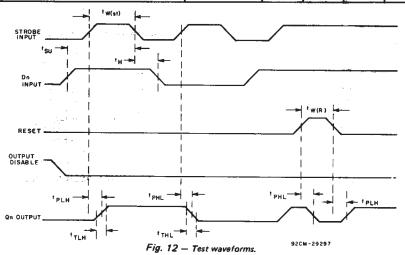






DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25°C; Input t_r, t_f = 20 ns, C_L = 50 pF, R_L = 200 k Ω , unless otherwise specified.

OULA DA OTEDIATIO	TEST		LIA	UNUTO	
CHARACTERISTIC	CONDITIONS	V _{DD}	Тур.	Max.	UNITS
		5	100	200	
Transition Time, tTHL, tTLH		10	50	100	
		15	40	80	
· · · · · · · · · · · · · · · · · · ·		5	100	200	
Minimum Reset Pulse Width, tw(R)		10	70	140	
		15	50	100	
		5	70	140	
Minimum Strobe Pulse Width, tW(st)		10	40	80	
44(21)		15	35	70	
		5	25	50	
Minimum Setup Time, t _{SU}		10	15	30	
-30		15	10	20	
		5	0	0	
Minimum Hold Time, t _H		10	0	0	
		15	0	0	
Propagation Delay Times: tpHL,tpLH		5	130	260	
Strobe to Data Out		10	70	140	
		15	50	100	ns
		5	105	210	113
Data In to Data Out	,	10	60	120	<i>2</i>
· · · · · · · · · · · · · · · · · · ·		15	45	90	
		5	90	180	
Reset to Data Out		10	50	100	
		15	40	80	
		5	90	180	
3-State Propagation Delay Times:		10	50	100	
Output High to High Impedance, tPHZ		15	35	70	
		5	90	180	
High Impedance to Output High, tP7H		10	50	100	
		15	35	70	
		5	90	180	
Output Low to High Impedance, tpLZ		10	50	100	
,,,		15	35	70	
		5	90	180	
High Impedance to Output Low, tpzL		10	50	100	
		15	35	70	
			5	7.5	pF



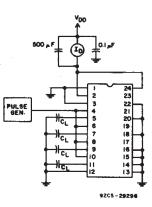
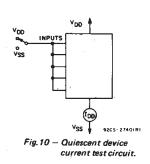
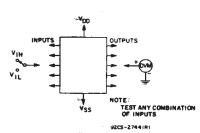


Fig.9 - Power dissipation test circuit.









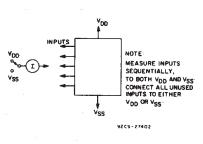


Fig. 13 - Input current test circuit.

CD4508B Types

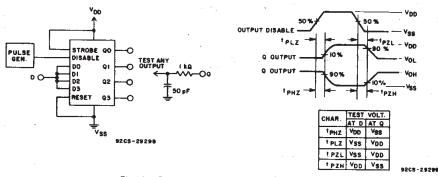
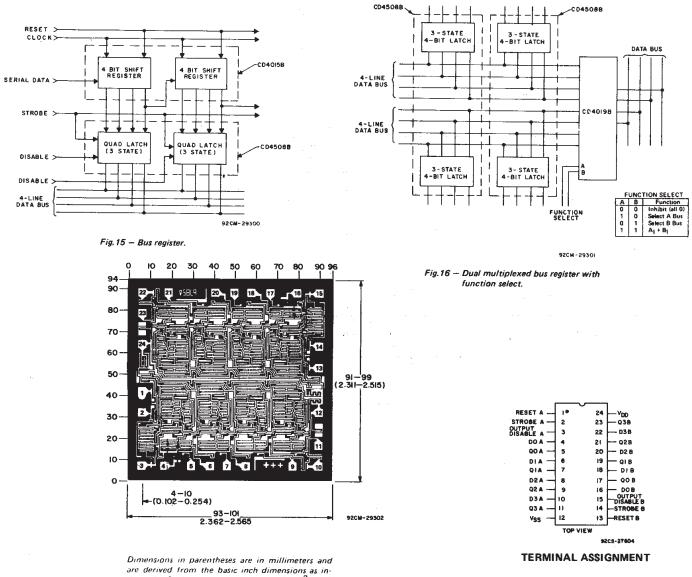


Fig. 14 - Output disable test circuit and waveforms.



are derived from the basic inch dimensions as in-dicated. Grid graduations are in mils (10^{-3} inch).

Chip dimensions and pad layout for CD4508B.



PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	Package	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
							(6)				
CD4508BD3	ACTIVE	CDIP SB	JD	24	15	Non-RoHS & Non-Green	SNPB	N / A for Pkg Type	-55 to 125	CD4508BD/3	Samples
CD4508BF3A	ACTIVE	CDIP	J	24	15	Non-RoHS & Non-Green	Call TI	N / A for Pkg Type	-55 to 125	CD4508BF3A	Samples
CD4508BM	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI	-55 to 125	CD4508BM	
CD4508BM96	ACTIVE	SOIC	DW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4508BM	Samples
CD4508BNSR	ACTIVE	SOP	NS	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4508B	Samples
CD4508BPW	ACTIVE	TSSOP	PW	24	60	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM508B	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

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OTHER QUALIFIED VERSIONS OF CD4508B, CD4508B-MIL :

- Catalog : CD4508B
- Military : CD4508B-MIL

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

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STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All	dimensions are nominal												
	Device	-	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	CD4508BM96	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
	CD4508BNSR	SOP	NS	24	2000	330.0	24.4	8.3	15.4	2.6	12.0	24.0	Q1



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PACKAGE MATERIALS INFORMATION

7-Dec-2024



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4508BM96	SOIC	DW	24	2000	350.0	350.0	43.0
CD4508BNSR	SOP	NS	24	2000	367.0	367.0	45.0

TEXAS INSTRUMENTS

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7-Dec-2024

TUBE



- B - Alignment groove width

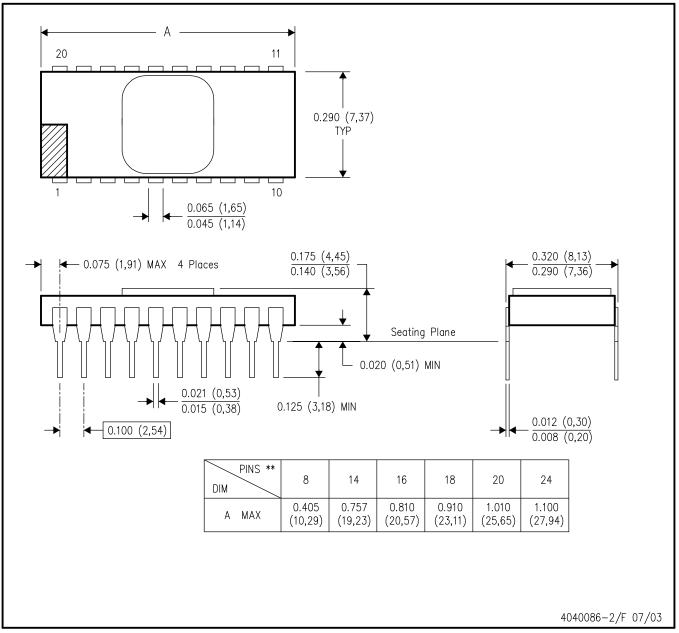
*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
CD4508BPW	PW	TSSOP	24	60	530	10.2	3600	3.5

JD (R-CDIP-T**)

CERAMIC SIDE-BRAZE DUAL-IN-LINE PACKAGE

20 PINS SHOWN



- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package is hermetically sealed with a metal lid.
 - D. The terminals are gold plated.
 - E. Falls within MIL STD 1835 CDIP2 T8, T14, T16, T18, T20 and T24 respectively.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.

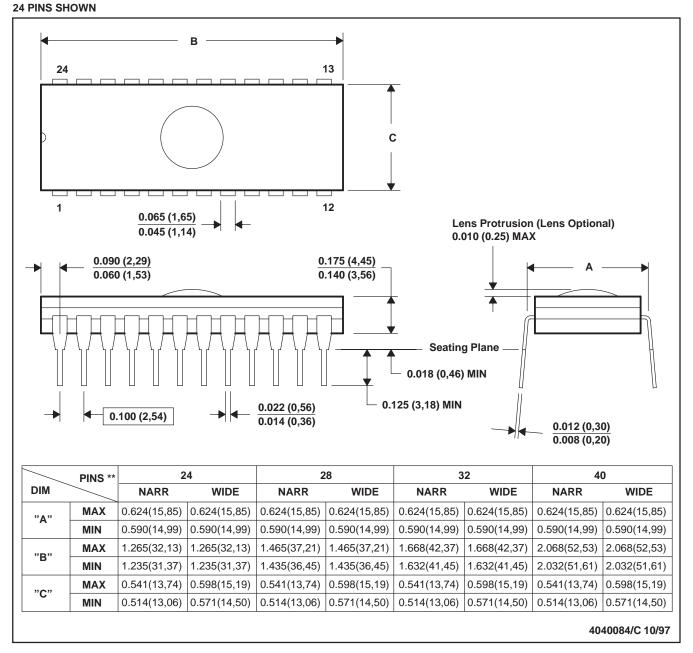


MECHANICAL DATA

MCDI004A - JANUARY 1995 - REVISED NOVEMBER 1997

CERAMIC DUAL-IN-LINE PACKAGE

J (R-GDIP-T**)



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Window (lens) added to this group of packages (24-, 28-, 32-, 40-pin).
- D. This package can be hermetically sealed with a ceramic lid using glass frit.
- E. Index point is provided on cap for terminal identification.



PW0024A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0024A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0024A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 \bigcirc Gage Plane ₽ 0,25 7 1 1,05 0,55 0-10 Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS ** 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G**)

14-PINS SHOWN

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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